

Search Notes

Application/Control No.

10/760,546

Examiner

Phu Vu

Applicant(s)/Patent under
Reexamination

YANO ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	118	4/10/2005	PV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR